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ACL Products	

74AC/ACT11646

Octal transceiver/register with direction pin (3-State)

FEATURES

- Octal bidirectional bus interface
- 3-State buffers
- Independent registers for A and B buses
- Multiplexed real-time and stored data
- Output capability: ± 24 mA
- CMOS (AC) and TTL (ACT) voltage level inputs
- 50Ω incident wave switching
- Center-pin V_{CC} and ground configuration to minimize high-speed switching noise
- I_{CC} category: MSI

DESCRIPTION

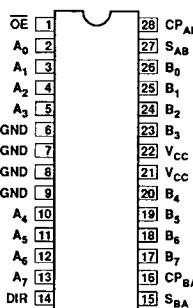
The 74AC/ACT11646 high-performance CMOS devices combine very high speed and high output drive comparable to the most advanced TTL families.

The 74AC/ACT11646 device is an octal transceiver/register featuring non-inverting 3-State bus compatible outputs in both send and receive directions, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the input bus or from internal

(continued)

PIN CONFIGURATION

N and D Packages



QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS		TYPICAL		UNIT
		T _{amb} = 25°C; GND = 0V; V _{CC} = 5.0V		AC	ACT	
t _{PLH} / t _{PHL}	Propagation delay A _n to B _n , or B _n to A _n	C _L = 50pF		5.9	7.3	ns
C _{PD}	Power dissipation capacitance per transceiver ¹	f = 1MHz;	Enabled	59	63	pF
		C _L = 50pF	Disabled	15	14	
C _{IN}	Input capacitance	V _I = 0V or V _{CC}		4.5	4.5	pF
C _{IO}	I/O capacitance	V _O = 0V or V _{CC} ; Disabled		12	12	pF
I _{LATCH}	Latch-up current	Per Jedec JC40.2 Standard 17		500	500	mA
f _{MAX}	Maximum clock frequency, CP _x to A or B	C _L = 50pF		125	125	MHz

Note:

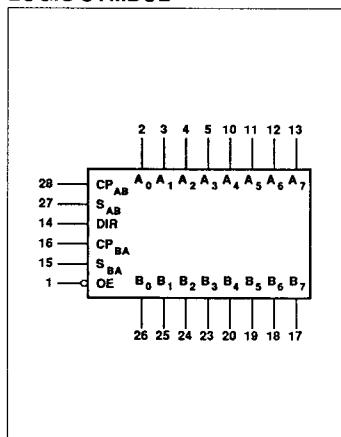
1. C_{PD} is used to determine the dynamic power dissipation (P_D in μ W):

$$P_D = C_{PD} \times V_{CC}^2 \times f_I + \sum (C_L \times V_{CC}^2 \times f_O)$$
 where:
 f_I = input frequency in MHz, C_L = output load capacitance in pF,
 f_O = output frequency in MHz, V_{CC} = supply voltage in V,
 $\sum (C_L \times V_{CC}^2 \times f_O)$ = sum of outputs

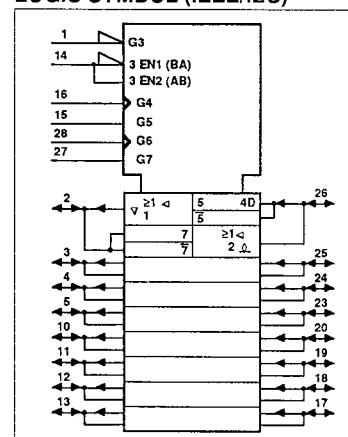
ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	ORDER CODE
28-pin plastic DIP (300mil-wide)	-40°C to +85°C	74AC11646N 74ACT11646N
28-pin plastic SOL (300mil-wide)	-40°C to +85°C	74AC11646D 74ACT11646D

LOGIC SYMBOL



LOGIC SYMBOL (IEEE/IEC)



Octal transceiver/register with direction pin (3-State)

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registers. Data on the A or B bus will be clocked into the registers as the appropriate clock pin goes to a High logic level. Output Enable (\overline{OE}) and DIR pins are provided to control the transceiver function. In the transceiver mode, data present at the High-impedance port may be stored in either the A or B register or both.

The Select inputs (S_x) can multiplex stored and real-time (transparent mode) data. The DIR input determines which bus will receive data when the Output Enable is active (Low). In the isolation mode (\overline{OE} is High), A data may be stored in the B register and/or B data may be stored in the A register.

When an output function is disabled, the input function is still enabled and may be used to store and transmit data. Only one of the two buses, A or B, may be driven at a time. Figure 1 demonstrates the four fundamental bus-management functions that can be performed.

PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
1	\overline{OE}	Output enable input (active Low)
28	CP_{AB}	A-to-B clock input
16	CP_{BA}	B-to-A clock input
27	S_{AB}	A-to-B select input
15	S_{BA}	B-to-A select input
14	DIR	Data flow directional control input
2, 3, 4, 5, 10, 11, 12, 13	$A_0 - A_7$	A side inputs/outputs (3-state)
26, 25, 24, 23, 20, 19, 18, 17	$B_0 - B_7$	B side inputs/outputs (3-state)
6, 7, 8, 9	GND	Ground (0V)
21, 22	V_{CC}	Positive supply voltage

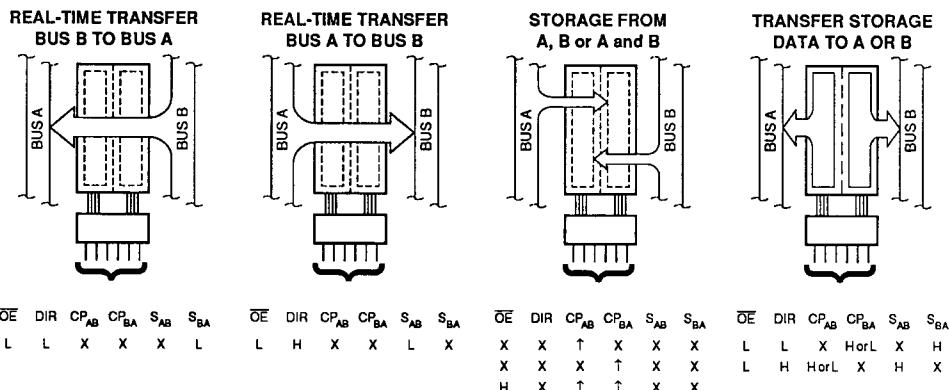


Figure 1

Octal transceiver/register with direction pin (3-State)

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FUNCTION TABLE

INPUTS						DATA I/O*		OPERATING MODE
OE	DIR	CP _{AB}	CP _{BA}	S _{AB}	S _{BA}	A ₀ - A ₇	B ₀ - B ₇	
X	X	↑	X	X	X	Input	un*	Store A, B unspecified*
X	X	X	↑	X	X	un*	Input	Store B, A unspecified*
H	X	↑	H or L	↑	X	Input	Input	Store A and B Data Isolation, hold storage
H	X	H or L	H or L	X	X			
L	L	X	X	H or L	X	L	Output	Real time B data to A bus Stored B Data to A Bus
L	L	X	X	H or L	X	H	Input	
L	H	X	X	L	H	X	Output	Real time A data to B bus Stored A data to B bus
L	H	H or L	X	H	X			

* The data output functions may be enabled or disabled by various signals at the OE and DIR inputs. Data input functions are always enabled, i.e., data at the bus pins will be stored on every Low-to-High transition of the clock.

un = unspecified

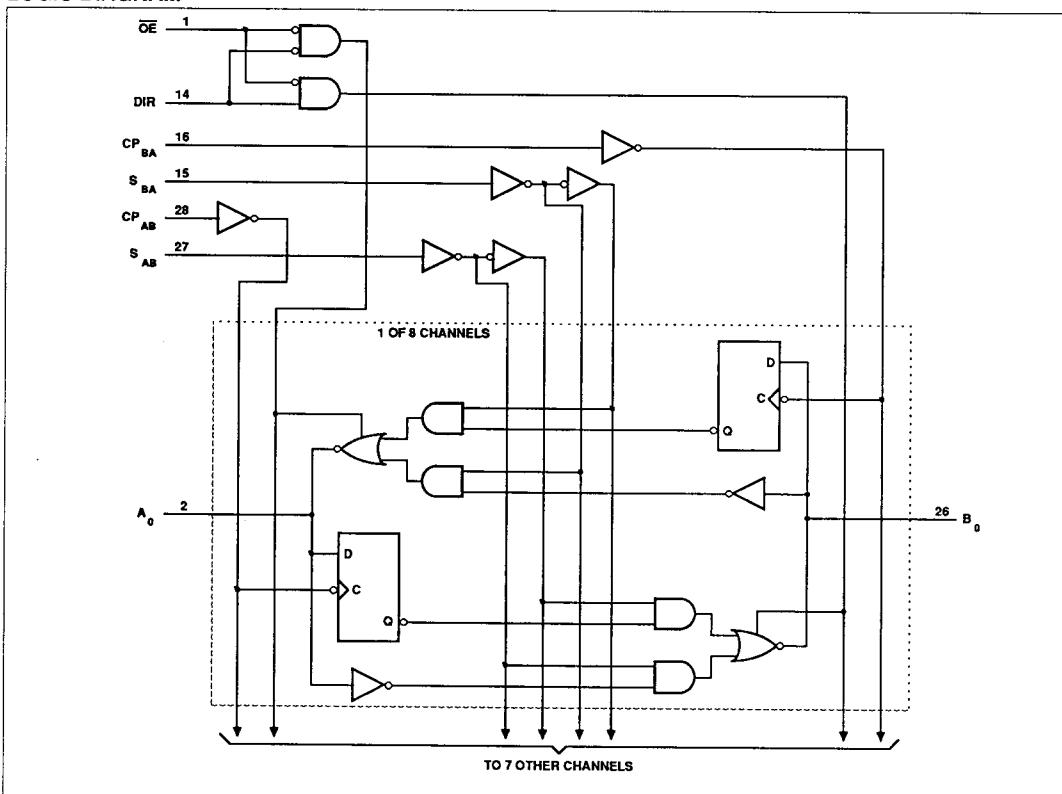
H = Highvoltage level

L = Low voltage level

X = Don't care

↑ = Low-to-High clock transition

LOGIC DIAGRAM



Octal transceiver/register with direction pin (3-State)

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RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	74AC11646			74ACT11646			UNIT
		Min	Nom	Max	Min	Nom	Max	
V _{CC}	DC supply voltage	3.0 ¹	5.0	5.5	4.5	5.0	5.5	V
V _I	Input voltage	0		V _{CC}	0		V _{CC}	V
V _O	Output voltage	0		V _{CC}	0		V _{CC}	V
Δt/ΔV	Input transition rise or fall rate	0		10	0		10	ns/V
T _{amb}	Operating free-air temperature range	-40		+85	-40		+85	°C

NOTE:

1. No electrical or switching characteristics are specified at V_{CC} < 3V. Operation between 2V and 3V is not recommended, but within that range, a device output will maintain a previously established logic state.

ABSOLUTE MAXIMUM RATINGS¹

SYMBOL	PARAMETER	TEST CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 TO +7.0	V
I _{IK} or V _I	DC input diode current ²	V _I < 0	-20	mA
		V _I > V _{CC}	20	
DC input voltage			-0.5 to V _{CC} + 0.5	V
I _{OK} or V _O	DC output diode current ²	V _O < 0	-50	mA
		V _O > V _{CC}	50	
DC output voltage			-0.5 to V _{CC} + 0.5	V
I _O	DC output source or sink current per output pin	V _O = 0 to V _{CC}	±50	mA
I _{CC} or I _{GND}	DC V _{CC} current		±200	mA
	DC ground current		±200	
T _{STG}	Storage temperature		-65 to 150	°C
P _{TOT}	Power dissipation per package	Above 70°C; derate linearly by 8mW/K	500	mW
	Power dissipation per package Plastic surface mount (SO)	Above 70°C; derate linearly by 8mW/K	400	mW

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

Octal transceiver/register with direction pin (3-State)

74AC/ACT11646
DC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITIONS	V_{CC}	74AC11646				74ACT11646				UNIT	
				$T_{amb} = +25^{\circ}C$		$T_{amb} = -40^{\circ}C$ to $+85^{\circ}C$		$T_{amb} = +25^{\circ}C$		$T_{amb} = -40^{\circ}C$ to $+85^{\circ}C$			
				V	Min	Max	Min	Max	Min	Max	Min		
V_{IH}	High-level input voltage			3.0	2.10		2.10					V	
				4.5	3.15		3.15		2.0		2.0		
				5.5	3.85		3.85		2.0		2.0		
V_{IL}	Low-level input voltage			3.0		0.90		0.90				V	
				4.5		1.35		1.35		0.8			
				5.5		1.65		1.65		0.8			
V_{OH}	High-level output voltage	$V_I = V_{IL}$ or V_{IH}	$I_{OH} = -50\mu A$	3.0	2.9		2.9					V	
				4.5	4.4		4.4		4.4		4.4		
				5.5	5.4		5.4		5.4		5.4		
				3.0	2.58		2.48						
			$I_{OH} = -4mA$	4.5	3.94		3.8		3.94		3.8	V	
				5.5	4.94		4.8		4.94		4.8		
			$I_{OH} = -24mA$	5.5		3.85				3.85			
			$I_{OH} = -75mA^1$	5.5									
V_{OL}	Low-level output voltage	$V_I = V_{IL}$ or V_{IH}	$I_{OL} = 50\mu A$	3.0		0.1		0.1				V	
				4.5		0.1		0.1		0.1			
				5.5		0.1		0.1		0.1			
				3.0		0.36		0.44					
			$I_{OL} = 12mA$	4.5		0.36		0.44		0.36		V	
				5.5		0.36		0.44		0.36			
			$I_{OL} = 24mA$	5.5									
			$I_{OL} = 75mA^1$	5.5				1.65			1.65		
I_I	Input leakage current	$V_I = V_{CC}$ or GND	5.5		± 0.1		± 1.0		± 0.1		± 1.0	μA	
I_{OZ}	3-State output off-state current	$V_I = V_L$ or V_{IH} , $V_0 = V_{CC}$ or GND	5.5		± 0.5		5.0		± 0.5		5.0	μA	
I_{CC}	Quiescent supply current	$V_I = V_{CC}$ or GND, $I_0 = 0mA$	5.5		8.0		80		8.0		80	μA	
ΔI_{CC}	Supply current, TTL inputs High ²	One input at 3.4V, other inputs at V_{CC} or GND	5.5						0.9		1.0	mA	

NOTES:

- Not more than one output should be tested at a time, and the duration of the test should not exceed 10ms.
- This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0V or V_{CC} .

**Octal transceiver/register
with direction pin (3-State)**
74AC/ACT11646
AC ELECTRICAL CHARACTERISTICS AT 3.3V $\pm 0.3V$

SYMBOL	PARAMETER	WAVEFORM	74AC11646					UNIT	
			$T_{amb} = +25^{\circ}\text{C}$			$T_{amb} = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$			
			Min	Typ	Max	Min	Max		
f_{MAX}	Maximum clock frequency	1	65	80		65		MHz	
t_{PLH} t_{PHL}	Propagation delay CP_{AB} or CP_{BA} to A_n or B_n	1	1.5 1.5	11.8 13.7	15.0 16.8	1.5 1.5	17.0 18.3	ns	
t_{PLH} t_{PHL}	Propagation delay A_n or B_n to B_n or A_n	3	1.5 1.5	9.1 10.7	12.1 13.4	1.5 1.5	13.8 14.5	ns	
t_{PLH} t_{PHL}	Propagation delay (A_n or B_n High) S_{BA} or S_{AB} to A_n or B_n	2	1.5 1.5	9.8 12.0	12.9 14.5	1.5 1.5	14.4 15.8	ns	
t_{PLH} t_{PHL}	Propagation delay (A_n or B_n Low) S_{BA} or S_{AB} to A_n or B_n	3	1.5 1.5	10.7 12.4	13.8 15.0	1.5 1.5	15.4 16.4	ns	
t_{PZH} t_{PZL}	Output Enable time \overline{OE} to A_n or B_n	5	1.5 1.5	13.0 16.1	16.4 20.4	1.5 1.5	18.7 21.8	ns	
t_{PZH} t_{PZL}	Output Enable time DIR to A_n or B_n	5	1.5 1.5	13.7 16.8	17.1 21.0	1.5 1.5	19.4 23.6	ns	
t_{PHZ} t_{PLZ}	Output disable time \overline{OE} to A_n or B_n	5	1.5 1.5	7.9 7.2	9.6 8.9	1.5 1.5	10.3 9.6	ns	
t_{PHZ} t_{PLZ}	Output disable time DIR to A_n or B_n	5	1.5 1.5	7.9 7.3	9.7 9.1	1.5 1.5	10.5 9.9	ns	
t_s	Setup time (High or Low) A_n or B_n to CP_{AB} or CP_{BA}	4	6.5			6.5		ns	
t_h	Hold time (High or Low) A_n or B_n to CP_{AB} or CP_{BA}	4	1.0			1.0		ns	
t_w	Pulse width (High or Low) CP_{AB} or CP_{BA}	1	7.7			7.7		ns	

**Octal transceiver/register
with direction pin (3-State)****74AC/ACT11646****AC ELECTRICAL CHARACTERISTICS AT 5.0V ±0.5V**

SYMBOL	PARAMETER	WAVEFORM	74AC11646					UNIT	
			T _{amb} = +25°C			T _{amb} = -40°C to +85°C			
			Min	Typ	Max	Min	Max		
t _{MAX}	Maximum clock frequency	1	100	125		100		MHz	
t _{pLH} t _{PHL}	Propagation delay CP _{AB} or CP _{BA} to A _n or B _n	1	1.5 1.5	7.0 8.2	9.7 11.0	1.5 1.5	11.0 12.2	ns	
t _{pLH} t _{PHL}	Propagation delay A _n or B _n to B _n or A _n	3	1.5 1.5	5.5 6.3	7.9 8.9	1.5 1.5	8.8 9.8	ns	
t _{pLH} t _{PHL}	Propagation delay (A _n or B _n High) S _{BA} or S _{AB} to A _n or B _n	2	1.5 1.5	5.9 7.2	8.4 9.8	1.5 1.5	9.4 10.7	ns	
t _{pLH} t _{PHL}	Propagation delay (A _n or B _n Low) S _{BA} or S _{AB} to A _n or B _n	3	1.5 1.5	6.3 7.3	8.9 9.9	1.5 1.5	9.9 11.0	ns	
t _{pZH} t _{PZL}	Output Enable time OE to A _n or B _n	5	1.5 1.5	7.8 8.5	10.7 11.9	1.5 1.5	12.0 13.1	ns	
t _{pZH} t _{PZL}	Output Enable time DIR to A _n or B _n	5	1.5 1.5	8.4 9.1	11.2 12.3	1.5 1.5	12.6 13.7	ns	
t _{pHZ} t _{PLZ}	Output disable time OE to A _n or B _n	5	1.5 1.5	5.9 5.9	8.4 7.7	1.5 1.5	8.9 8.3	ns	
t _{pHZ} t _{PLZ}	Output disable time DIR to A _n or B _n	5	1.5 1.5	6.3 5.7	8.2 7.5	1.5 1.5	8.7 8.1	ns	
t _s	Setup time (High or Low) A _n or B _n to CP _{AB} or CP _{BA}	4	4.5			4.5		ns	
t _h	Hold time (High or Low) A _n or B _n to CP _{AB} or CP _{BA}	4	1.0			1.0		ns	
t _w	Pulse width (High or Low) CP _{AB} or CP _{BA}	1	5.0			5.0		ns	

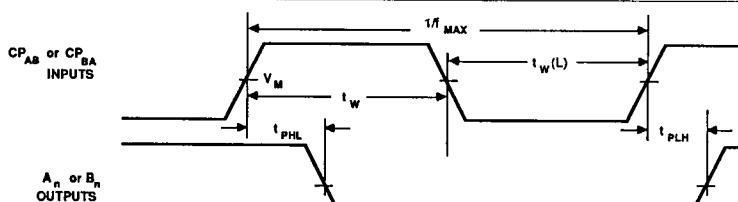
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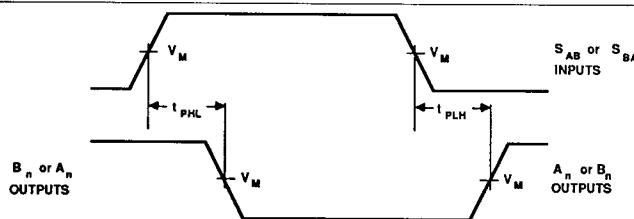
AC ELECTRICAL CHARACTERISTICS AT $5.0V \pm 0.5V$

SYMBOL	PARAMETER	WAVEFORM	74ACT11646					UNIT	
			$T_{amb} = +25^{\circ}\text{C}$			$T_{amb} = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$			
			Min	Typ	Max	Min	Max		
f_{MAX}	Maximum clock frequency	1	100	125		100		MHz	
t_{PLH} t_{PHL}	Propagation delay CP_{AB} or CP_{BA} to A_n or B_n	1	1.5 1.5	8.8 10.0	11.9 13.4	1.5 1.5	13.5 14.9	ns	
t_{PLH} t_{PHL}	Propagation delay A_n or B_n to B_n or A_n	3	1.5 1.5	7.3 7.2	10.1 11.0	1.5 1.5	11.5 12.0	ns	
t_{PLH} t_{PHL}	Propagation delay (A_n or B_n High) S_{BA} or S_{AB} to A_n or B_n	2	1.5 1.5	6.7 9.1	10.3 12.1	1.5 1.5	11.5 13.5	ns	
t_{PLH} t_{PHL}	Propagation delay (A_n or B_n Low) S_{BA} or S_{AB} to A_n or B_n	3	1.5 1.5	8.0 8.1	10.9 11.9	1.5 1.5	12.4 13.1	ns	
t_{PZH} t_{PZL}	Output Enable time \overline{OE} to A_n or B_n	5	1.5 1.5	7.7 9.2	12.8 13.8	1.5 1.5	14.4 15.3	ns	
t_{PZH} t_{PZL}	Output Enable time DIR to A_n or B_n	5	1.5 1.5	10.2 10.9	13.7 14.8	1.5 1.5	15.3 16.5	ns	
t_{PHZ} t_{PLZ}	Output disable time \overline{OE} to A_n or B_n	5	1.5 1.5	8.6 7.8	10.7 9.7	1.5 1.5	11.6 10.6	ns	
t_{PHZ} t_{PLZ}	Output disable time DIR to A_n or B_n	5	1.5 1.5	7.9 7.3	10.5 9.5	1.5 1.5	11.3 10.3	ns	
t_s	Setup time (High or Low) A_n or B_n to CP_{AB} or CP_{BA}	4	4.5			4.5		ns	
t_h	Hold time (High or Low) A_n or B_n to CP_{AB} or CP_{BA}	4	2.5			2.5		ns	
t_w	Pulse width (High or Low) CP_{AB} or CP_{BA}	1	5.0			5.0		ns	

AC WAVEFORMS



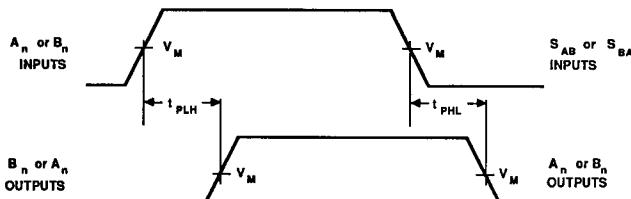
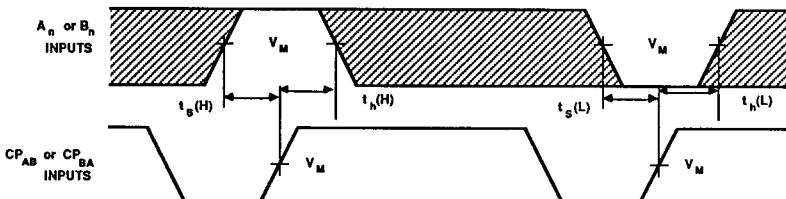
Waveform 1. Waveforms Showing Clock to Outputs Propagation Delays and Clock Pulse Width

Waveform 2. Waveforms Showing Propagation Delay, S_{BA} or S_{AB} to A_n or B_n

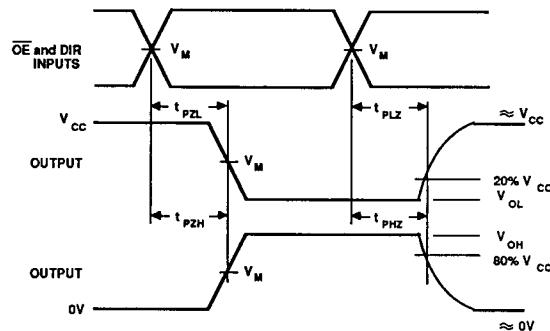
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AC WAVEFORMS (Continued)

Waveform 3. Waveforms Showing Propagation Delay, A_n to B_n or B_n to A_n and S_{BA} or S_{AB} to A_n or B_n 

Waveform 4. Waveforms Showing the Data Setup and Hold Times



Waveform 5. Waveforms Showing 3-State Output Enable and Disable Times

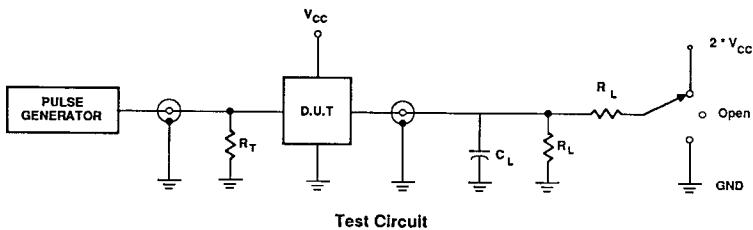
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WAVEFORM CONDITIONS

	INPUTS	OUTPUTS
AC	$V_{IN} = GND$ to V_{CC} , $V_M = 50\% V_{CC}$	$V_{OUT} = V_{OL}$ to V_{OH}
ACT	$V_{IN} = GND$ to 3.0V, $V_M = 1.5V$	$V_M = 50\% V_{CC}$

TEST CIRCUIT



TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	$2 \cdot V_{CC}$
t_{PHZ}/t_{PZH}	GND

SWITCH POSITION

DEFINITIONS

C_L = Load capacitance, 50pF; includes jig and probe capacitance
 R_L = Load resistor, 500Ω
 R_T = Termination resistance should be equal to Z_{OUT} of pulse generators
 Input pulses: PRR ≤ 10MHz
 $t_r = t_f = 3\text{ns}$